	Application/Control No.	Applicant(s)	Applicant(s)/Patent under Reexamination	ion
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	Examiner	Art Unit		
	Bhatia, Ajay M	2145		
ORIGINAL	INAL	INTERNATION	INTERNATIONAL CLASSIFICATION	N
CLASS	SUBCLASS	CLAIMED	NON-CLAIMED	VIMED
709	217	G 0 6 F 15 / 16		
CROSS REFERENCE(S)	ERENCE(S)			
CLASS SUBCLASS (ON	SUBCLASS (ONE SUBCLASS PER BLOCK)			
(Assistant Experiment) (Date)	200		Total Claims Allowed:	Allowed:
(Legal Instruments Examiner) (Date)	JASON CARDONE  " المجابة المجابة (Primary Examiner) (Date)	IT EXAMINER (Date) 6/9/06	O.G. Print Claim(s) 1	O.G. Print Figure 8

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